

Docket No.: 60188-075

**PATENT** 

## IN THE UNITED STATES PATENT AND TRADEMERK OFFICE

In re Application of

Makoto FUJIWARA

Serial No.:

Group Art Unit:

Filed: May 31, 2001

Examiner:

For:

SEMICONDUCTOR INTEGRATED CIRCUIT AND METHOD OF TESTING

SEMICONDUCTOR INTEGRATED CIRCUIT

## INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents Washington, DC 20231

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits.

## No certification or fee is required.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

Michael E. Fogarty Registration No. 36,139

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Date: May 31, 2001

Facsimile: (202) 756-8087

. INFORMATION DISCLOSURE CITATION IN AN APPLICATION				ATTY. DOCKET NO. <b>60188-075</b>		SERIAL NO.		
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(PTO-1449)				FILING DATE May 31, 2001		GROUP		17
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EXAMINER'S INITIALS	PATENT NO.	DATE		NAME	CLASS	SUBCLASS	FILI	ING DATE
	4,905,142	FEB. 27, 1990	MATSUBARA, ET AL.  MCGUINNESS					
	6,006,354	DEC. 21, 1999						
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.